

Search Notes

Application/Control No.

10/670,269

Examiner

Jean E. Lesperance

Applicant(s)/Patent under
Reexamination

HSIEH, YOU-JUN

Art Unit

2629

SEARCHED

Class	Subclass	Date	Examiner
345	168	10/16/2006	JL
345	169	10/16/2006	JL
345	170	10/16/2006	JL
345	171	10/16/2006	JL
345	172	10/16/2006	JL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East search and copy attached.	10/16/2006	JL